

• General Description

It combines trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ . It combines one N channel MOSFET and one P channel MOSFET

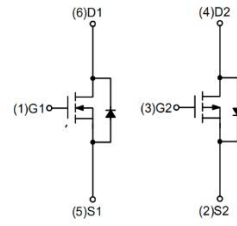
• Features

- AEC-Q101 Qualified
- Low  $R_{DS(ON)}$  to minimize conductive loss
- Dual DIE in one package
- Low Thermal resistance

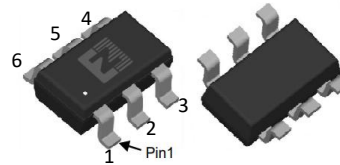
• Application

- BLDC Motor driver
- Load switch

• Product Summary



$V_{DS1} = 40V$   
 $V_{DS2} = -40V$   
 $R_{DS(ON)1} = 38m\Omega$   
 $R_{DS(ON)2} = 96m\Omega$   
 $I_{D1} = 3.8A$   
 $I_{D2} = -2.4A$



SOT23-6



• Ordering Information:

Part NO.	ZMCA88402U
Marking	88402
Packing Information	REEL TAPE
Basic ordering unit (pcs)	3000

• N Channel Absolute Maximum Ratings ( $T_C=25^\circ C$ )

Parameter	Symbol	Conditions	Value	Unit
Drain-Source Voltage	$V_{DS}$		40	V
Gate-Source Voltage <sup>①</sup>	$V_{GS}$		$\pm 20$	V
Continuous Drain Current	$I_D$	$T_C=25^\circ C$	3.8	A
	$I_D$	$T_C=75^\circ C$	3	A
	$I_D$	$T_C=100^\circ C$	2	A
Pulsed Drain Current	$I_{DM}$	Pulsed; $t_p \leq 10 \mu s$ ; $T_{mb} = 25^\circ C$ ;	11.4	A
Total Power Dissipation	$P_D$	$T_C=25^\circ C$	2	W
Total Power Dissipation	$P_D$	$T_A=25^\circ C$	0.7	W
Operating Junction Temperature	$T_J$		-55 to +150	$^\circ C$
Storage Temperature	$T_{STG}$		-55 to +150	$^\circ C$
Single Pulse Avalanche Energy	$E_{AS}$	$L=0.1mH, V_{GS}=10V, R_g=25\Omega,$	1.5	mJ
		$L=0.5mH, V_{GS}=10V, R_g=25\Omega,$	3.15	mJ
ESD Level (HBM)	CLASS 1A			

**•P Channel Absolute Maximum Ratings ( $T_C=25^\circ\text{C}$ )**

Parameter	Symbol	Conditions	Value	Unit
Drain-Source Voltage	$V_{DS}$		-40	V
Gate-Source Voltage <sup>②</sup>	$V_{GS}$		$\pm 20$	V
Continuous Drain Current	$I_D$	$T_C=25^\circ\text{C}$	-2.4	A
	$I_D$	$T_C=75^\circ\text{C}$	-2	A
	$I_D$	$T_C=100^\circ\text{C}$	-2	A
Pulsed Drain Current	$I_{DM}$	Pulsed; $t_p \leq 10 \mu\text{s}$ ; $T_{mb} = 25^\circ\text{C}$ ;	-7.2	A
Total Power Dissipation	$P_D$	$T_C=25^\circ\text{C}$	2	W
Total Power Dissipation	$P_D$	$T_A=25^\circ\text{C}$	0.7	W
Operating Junction Temperature	$T_J$		-55 to +150	$^\circ\text{C}$
Storage Temperature	$T_{STG}$		-55 to +150	$^\circ\text{C}$
Single Pulse Avalanche Energy	$E_{AS}$	$L=0.1\text{mH}$ , $V_{GS}=-10\text{V}$ , $R_g=25\Omega$ ,	1.5	mJ
		$L=0.5\text{mH}$ , $V_{GS}=-10\text{V}$ , $R_g=25\Omega$ ,	3	mJ
ESD Level (HBM)	CLASS 1A			

**•Thermal resistance**

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	$R_{thJC}$		-	80	$^\circ\text{C/W}$
Thermal resistance, junction-ambient <sup>③</sup>	$R_{thJA}$		-	180	$^\circ\text{C/W}$
Soldering temperature	$T_{sold}$		-	260	$^\circ\text{C}$

**•N Channel Electronic Characteristics**

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=250\mu A$	40			V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	1.3	1.7	2.5	V
Drain-Source Leakage Current	$I_{DSS}$	$V_{GS}=0V, V_{DS}=40V$			1.0	$\mu A$
Gate- Source Leakage Current	$I_{GSS}$	$V_{GS}=\pm 20V, V_{DS}=0V$			100	nA
Static Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=4A$		38	49	m $\Omega$
		$V_{GS}=4.5V, I_D=3A$		60	78	m $\Omega$
Forward Transconductance	$g_{FS}$	$V_{DS}=5V, I_{SD}=1A$		1.8		S
Diode Forward Voltage	$V_{FSD}$	$V_{GS}=0V, I_{SD}=4A$			1.3	V

**•N Channel Dynamic characteristics**

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input capacitance	$C_{iss}$	$f=1MHz, V_{DS}=25V$	-	463	-	pF
Output capacitance	$C_{oss}$		-	38	-	
Reverse transfer capacitance	$C_{rss}$		-	27	-	
Gate Resistance	$R_g$	$f=1MHz$	-	1.4		$\Omega$
Total gate charge	$Q_g$	$V_{DD}=15V, I_D=2A, V_{GS}=10V$	-	6.5	-	nC
	$Q_g(4.5v)$		-	3.1	-	
Gate - Source charge	$Q_{gs}$		-	1.4	-	
Gate - Drain charge	$Q_{gd}$		-	1.2	-	
Turn-ON Delay time	$t_{D(on)}$		$V_{GS}=10V, V_{DS}=15V, R_G=3.3\Omega, I_D=2A$	-	9	
Turn-ON Rise time	$t_r$	-		2	-	ns
Turn-Off Delay time	$t_{D(off)}$	-		10	-	ns
Turn-Off Fall time	$t_f$	-		8	-	ns
Reverse Recovery Time	$t_{RR}$	$V_{DD}=20V, di_s/dt=100A/\mu s, I_S=2A$	-	32	-	ns
Reverse Recovery Charge	$Q_{RR}$		-	25	-	nC

**•P Channel Electronic Characteristics**

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=-250\mu A$	-40			V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS}=V_{DS}, I_D=-250\mu A$	-1.3	-1.7	-2.5	V
Drain-Source Leakage Current	$I_{DSS}$	$V_{GS}=0V, V_{DS}=-40V$			1.0	$\mu A$
Gate- Source Leakage Current	$I_{GSS}$	$V_{GS}=\pm 20V, V_{DS}=0V$			100	nA
Static Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS}=-10V, I_D=-4A$		96	130	m $\Omega$
		$V_{GS}=-4.5V, I_D=-3A$		170	220	m $\Omega$
Forward Transconductance	$g_{FS}$	$V_{DS}=-5V, I_{SD}=-1A$		1.2		S
Diode Forward Voltage	$V_{FSD}$	$V_{GS}=0V, I_{SD}=-4A$			1.3	V

**•P Channel Dynamic characteristics**

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input capacitance	$C_{iss}$	$f=1MHz, V_{DS}=-25V$	-	421	-	$\mu F$
Output capacitance	$C_{oss}$		-	47	-	
Reverse transfer capacitance	$C_{rss}$		-	35	-	
Gate Resistance	$R_g$	$f=1MHz$	-	9.2		$\Omega$
Total gate charge	$Q_g$	$V_{DD}=-15V, I_D=-2A, V_{GS}=-10V$	-	7.3	-	nC
	$Q_g(4.5v)$		-	3.5	-	
Gate - Source charge	$Q_{gs}$		-	1.8	-	
Gate - Drain charge	$Q_{gd}$		-	1.3	-	
Turn-ON Delay time	$t_{D(on)}$		-	10	-	
Turn-ON Rise time	$t_r$	$V_{GS}=-10V, V_{DS}=-15V,$	-	7	-	ns
Turn-Off Delay time	$t_{D(off)}$	$R_G=3.3\Omega, I_D=-2A$	-	13	-	ns
Turn-Off Fall time	$t_f$		-	16	-	ns
Reverse Recovery Time	$t_{RR}$	$V_{DD}=-20V, dI_S/dt =$	-	42	-	ns
Reverse Recovery Charge	$Q_{RR}$	$100A/\mu s, I_S=-2A$	-	43	-	nC

• N Channel characteristics curve

Fig.1 Gate-Charge Characteristics

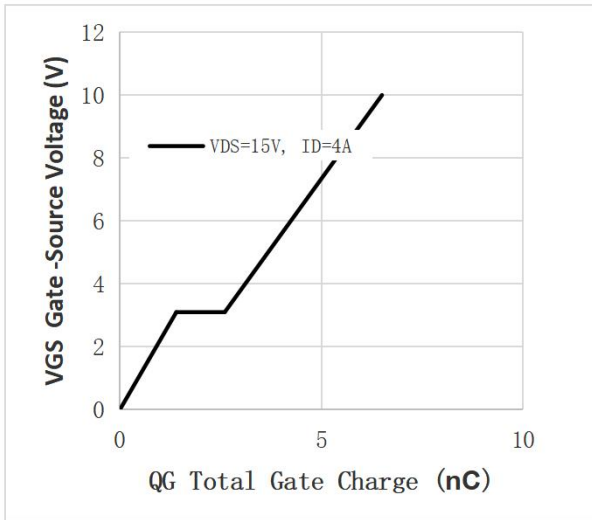


Fig.2 Capacitance Characteristics

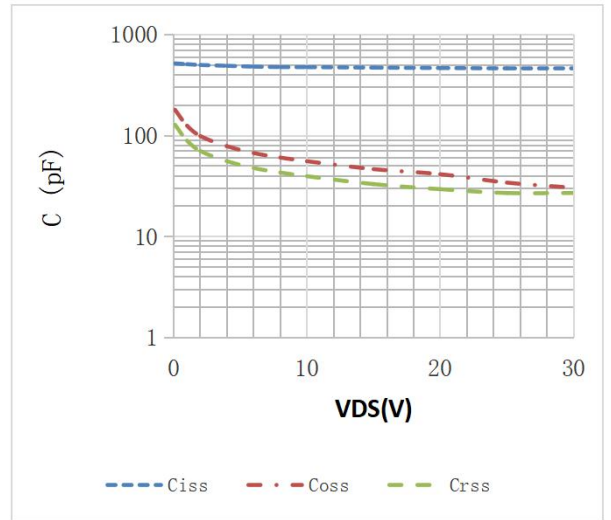


Fig.3 Power Dissipation

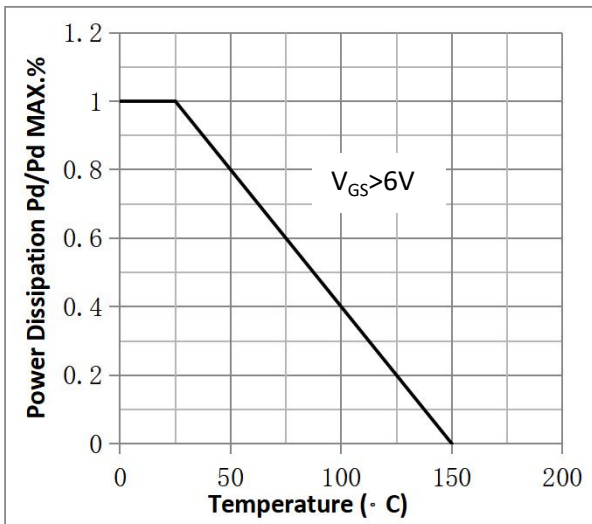


Fig.4 Typical output Characteristics

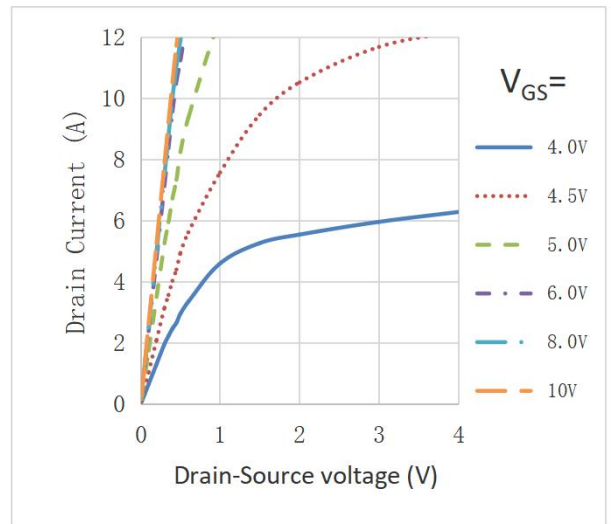


Fig.5 Threshold Voltage V.S Junction Temperature

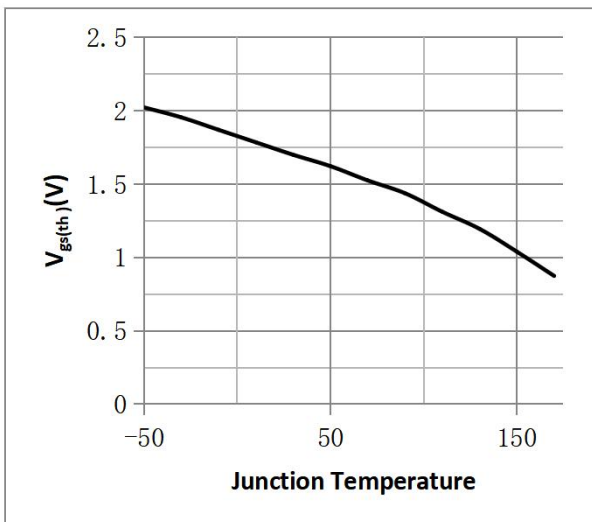


Fig.6 Resistance V.S Drain Current

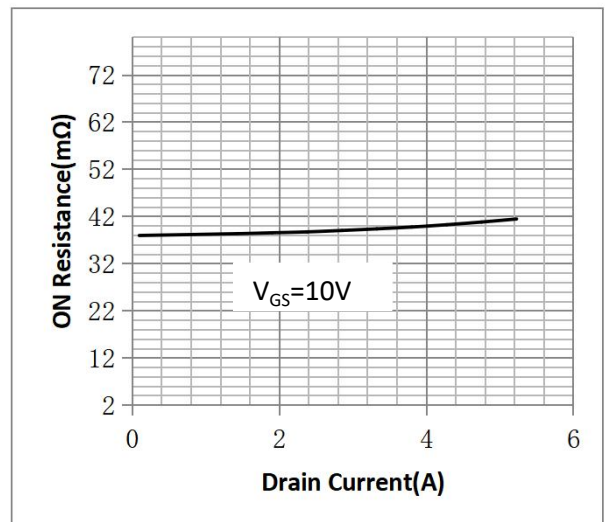


Fig.7 On-Resistance VS Gate Source Voltage

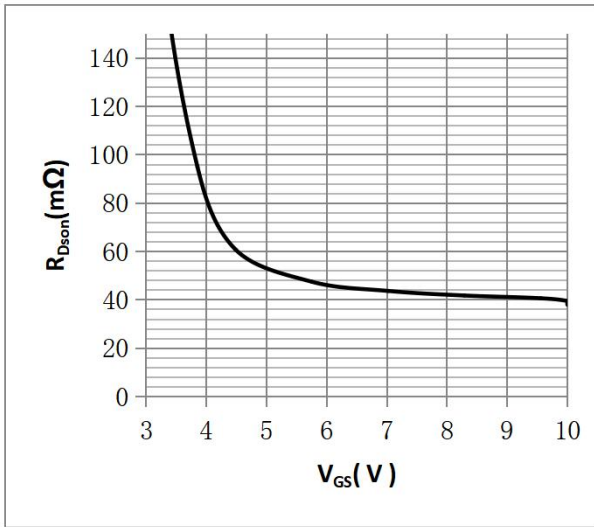


Fig.8 On-Resistance V.S Junction Temperature

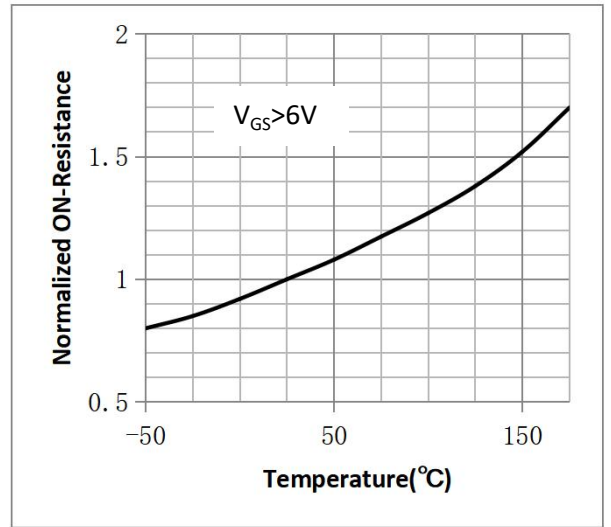


Figure 9. Diode Forward Voltage vs. Current

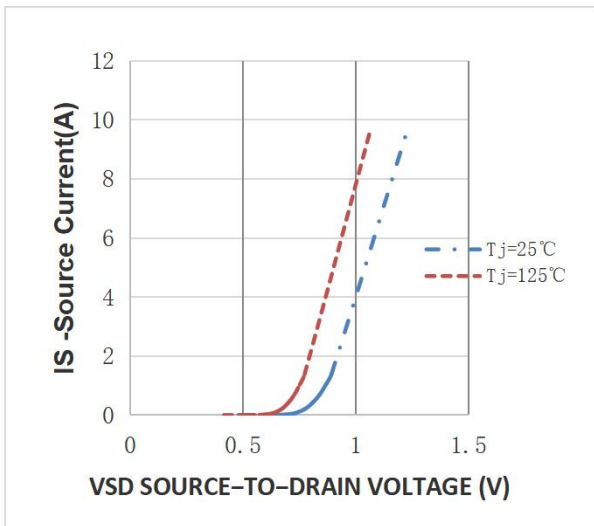


Figure 10. Transfer Characteristics

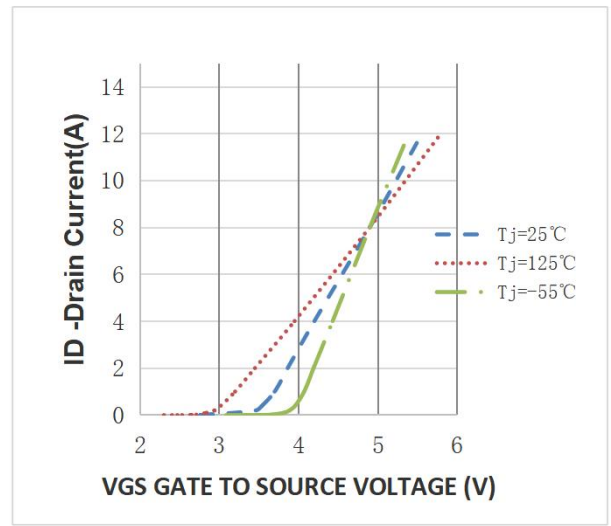


Fig.11 Safe Operating Area

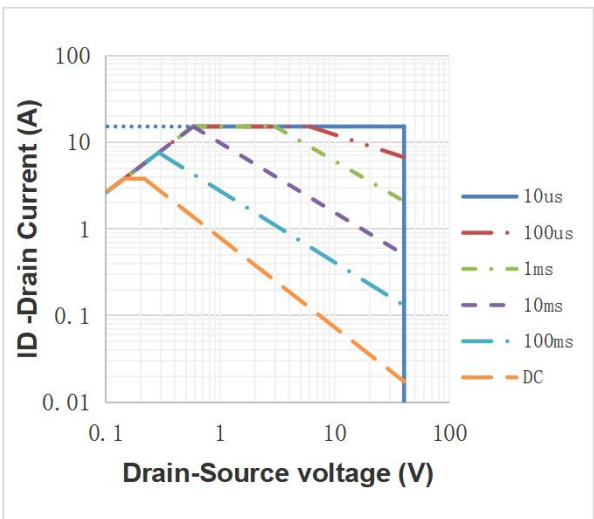
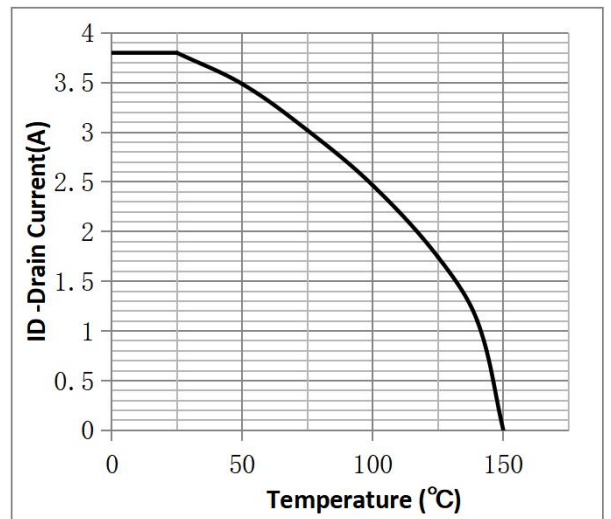


Fig.12 ID vs. Case Temperature<sup>④</sup>



• Channel characteristics curve

Fig.1 Gate-Charge Characteristics

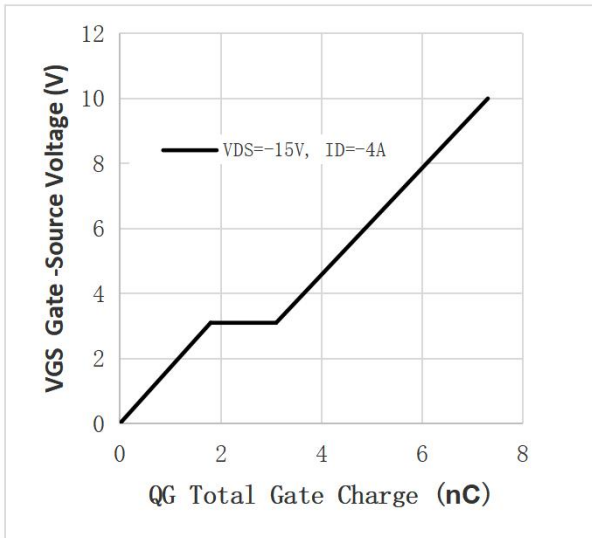


Fig.2 Capacitance Characteristics

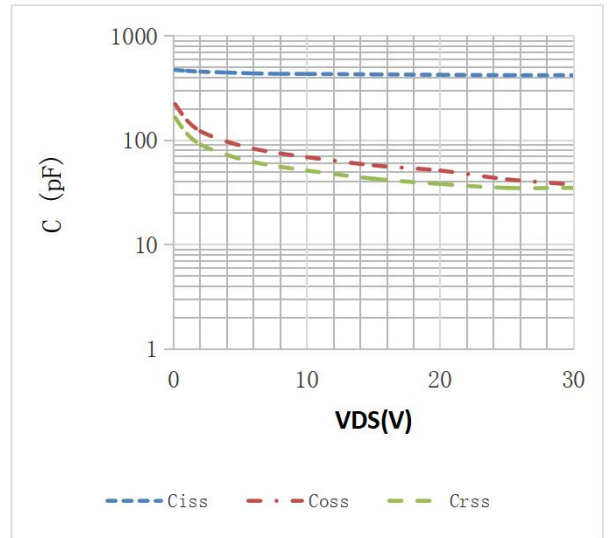


Fig.3 Power Dissipation

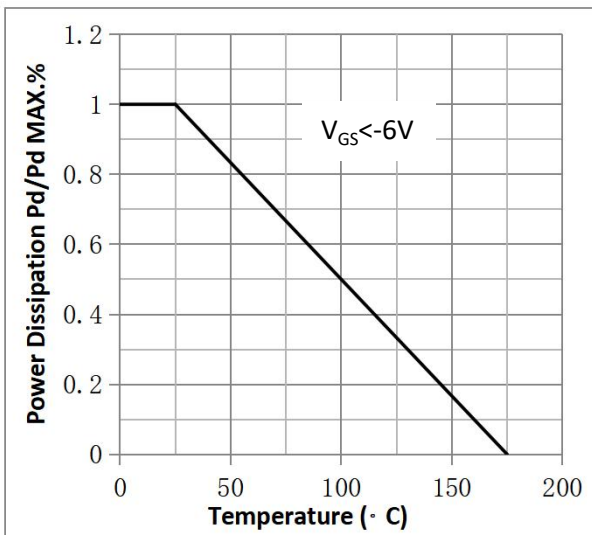


Fig.4 Typical output Characteristics

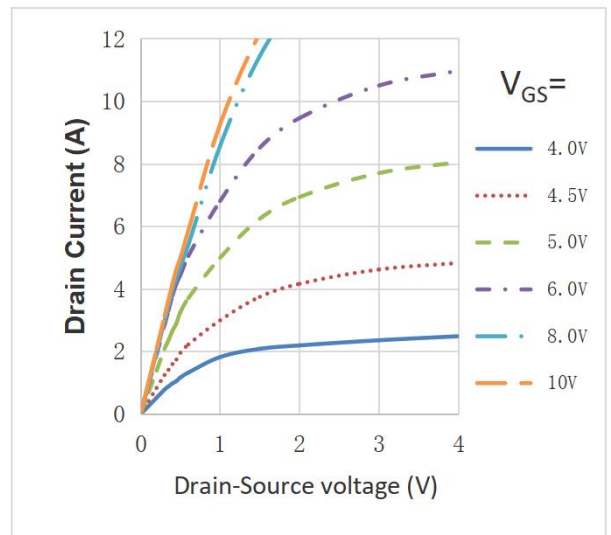


Fig.5 Threshold Voltage V.S Junction Temperature

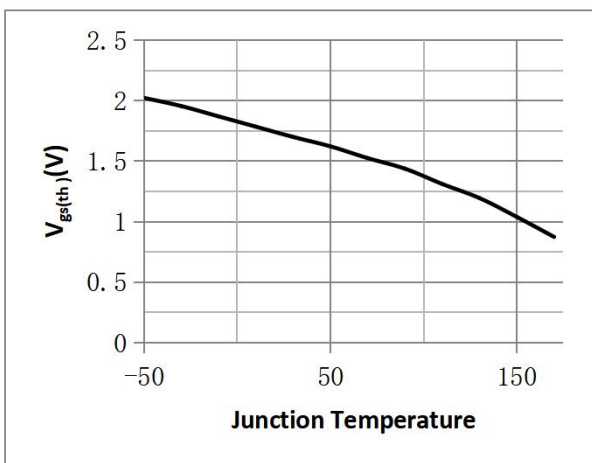


Fig.6 Resistance V.S Drain Current

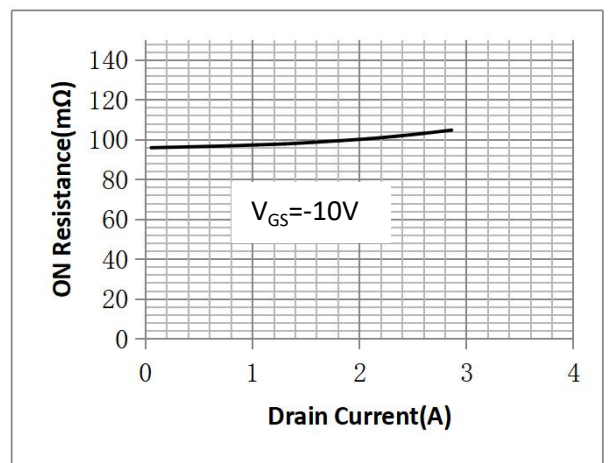


Fig.7 On-Resistance VS Gate Source Voltage

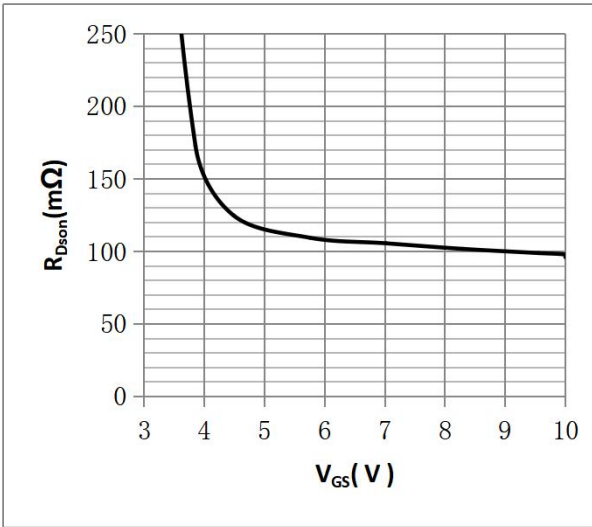


Fig.8 On-Resistance V.S Junction Temperature

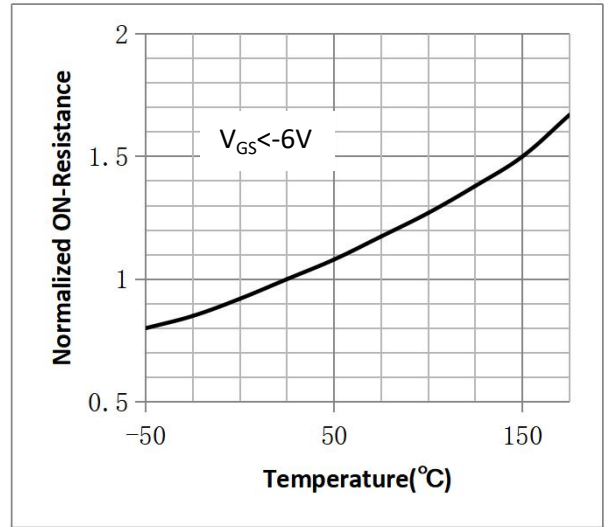


Figure 9. Diode Forward Voltage vs. Current

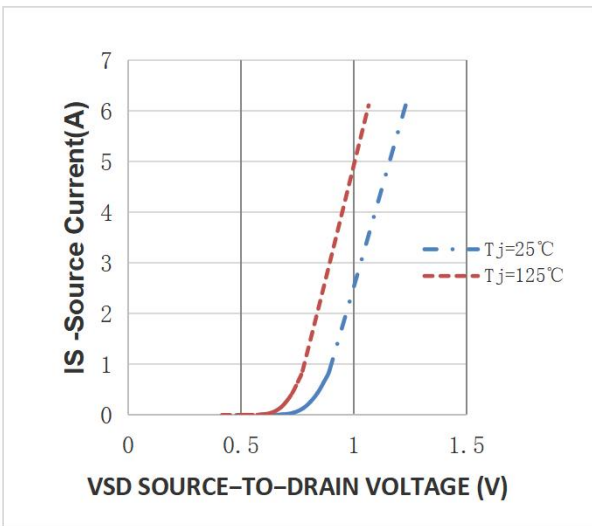


Figure 10. Transfer Characteristics

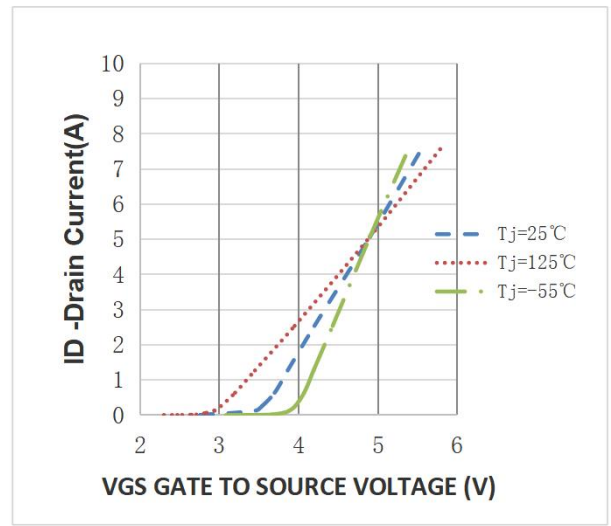


Fig.11 Safe Operating Area

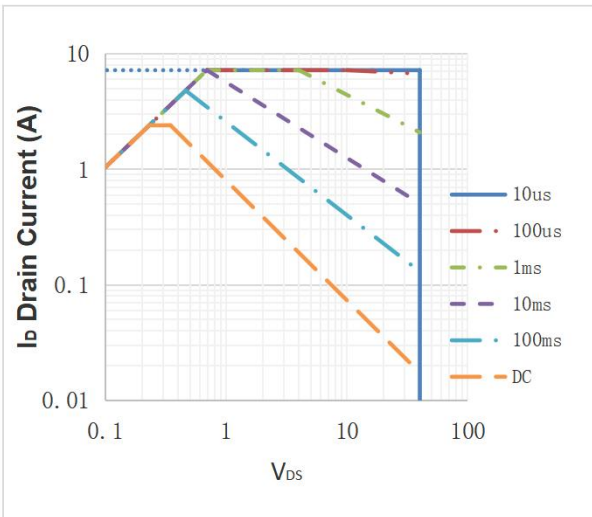
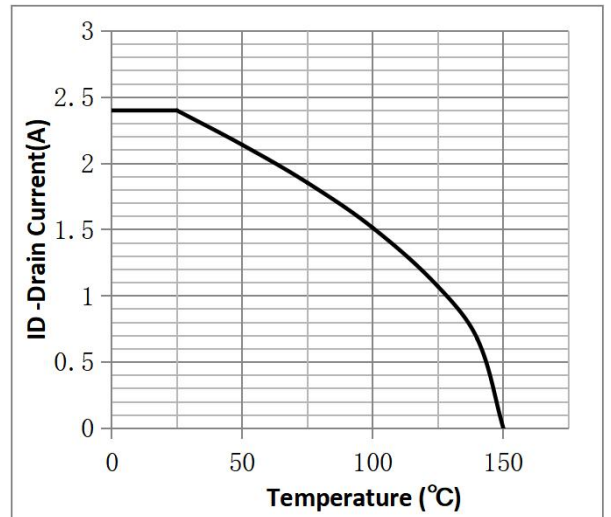
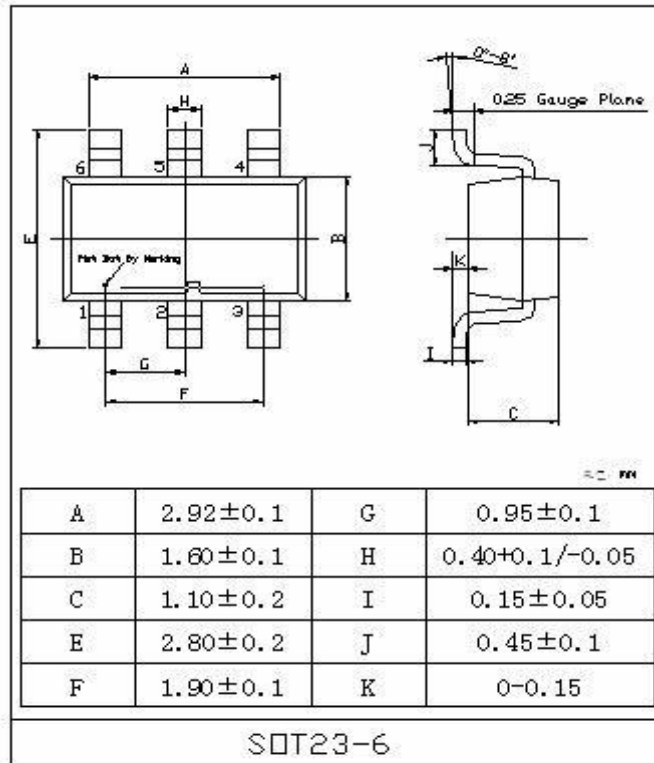


Fig.12 ID vs. Case Temperature<sup>④</sup>





•SOT23-6 Package Outline



**Note:**

- ① Pulse : VGS=+20V/-20V, Duty cycle=50%, Tj=175°C, t=1000 hours; For DC , the following test conditions can be passed: VGS=+20V/-10V, Tj=175°C, t=1000 hours;
- ② Pulse : VGS=+20V/-20V, Duty cycle=50%, Tj=175°C, t=1000 hours; For DC , the following test conditions can be passed: VGS=-20V/+10V, Tj=175°C, t=1000 hours;
- ③ Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;
- ④ Practically the current will be limited by PCB, thermal design and operating temperature. VGS=10V (N channel)/-10V(P channel).

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Revision History

Version	Date	Change
A	2023.6.16	NEW